## Notice of References Cited Application/Control No. 10/791,452 Examiner Andrew L. Nalven Applicant(s)/Patent Under Reexamination FURUKAWA ET AL. Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0153749	08-2004	Schwarm et al.	714/011
*	В	US-7,137,145	11-2006	Gleichauf, Robert E.	726/24
*	С	US-2002/0019870	02-2002	Chirashnya et al.	709/224
*	D	US-7,185,266	02-2007	Blightman et al.	714/776
*	E	US-6,622,220	09-2003	Yoshida et al.	711/152
	F	US-			
	G	US-			
	Н	US-			
	_	US-			
	J	US-			
	К	US-			
	L	US-			,
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					·
	Q					
	R					
	s					
	Т					·

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	>	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.